

<b>Notice of References Cited</b>	Application/Control No. 10/594,624	Applicant(s)/Patent Under Reexamination ABE ET AL.	
	Examiner JORGE L. ORTIZ CRIADO	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,757,748	05-1998	Kiyoura et al.	369/44.29
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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